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Band alignment of SnS/Zn(O,S) heterojunctions in SnS thin film solar cells

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Band alignment is critical to the performance of heterojunction thin film solar cells. In this letter, we report band alignment studies of SnS/Zn(O,S) heterojunctions with various compositions of ZnO:Sx. Valence band offsets (VBOs) are measured by femtosecond laser pump/probe ultraviolet photoelectron spectroscopy (fs-UPS) from which conduction band offsets (CBOs) are calculated by combining with band gaps obtained by optical transmission/reflection measurements. The SnS/Zn(O,S) heterojunctions with S/Zn ratios of 0.37 and 0.50 have desirable small positive CBOs, while a ratio of 0.64 produces an undesirable large positive CBO. The results are consistent with the device performance of SnS/Zn(O,S) solar cells. © 2013 AIP Publishing LLC.

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sample transfer. Transfer to the ultra-high vacuum UPS analysis system exposed the samples to less than 5 min of room atmosphere. Any adsorbed atmospheric water was desorbed by annealing to 150 °C for 10 s while under vacuum.

The valence band offsets (VBOs) of the SnS/Zn(O,S) heterojunctions were measured by using femtosecond ultraviolet photoelectron spectroscopy (fs-UPS). Fs-UPS measures key heterojunction electronic properties, such as valence band maximum (VBM), band bending, and Fermi level under flat band conditions. This technique has recently been applied to a number of absorber/buffer heterostructures.28–30 Briefly, fs-UPS utilizes synchronized 800 nm (1.55 eV) pulses of photons from an amplified Ti:sapphire laser system operating at a 1 kHz repetition rate. The light pulses are split into time-synchronized pump and probe arms. The probe pulses are frequency up-converted to energies ranging from 15 to 40 eV by high harmonic generation in Ar gas and are spectrally selected and focused onto the sample for measurements. Typically, 26.35 eV photons (17th harmonic) are used to generate fs-UPS spectra. To extract the band bending at the heterojunctions, the pump pulses are focused on the probe area. This generates an electron-hole population in SnS that screens the static dipole field in the depletion region and flattens the SnS bands, resulting in a rigid energetic shift of the spectrum. The band bending of the SnS is determined by measuring this shift. Since the 800 nm (1.55 eV) pump pulses cannot be absorbed in Zn(O,S), the Zn(O,S) bands are not flattened and the band bending cannot be measured. To circumvent this problem, the Zn(O,S) layer was kept thin so that any small band bending in this layer would only minimally impact the band offsets extracted from the measurements.

Figure 2(a) shows the fs-UPS spectra for unpumped and pumped bare SnS. The VBM of SnS under flat band conditions was identified from the pumped spectrum by linear extrapolation of the valence band edge to zero intensity. The extrapolation yielded a binding energy of 0.28 eV relative to the Fermi level in the bulk. As shown in Figure 2(a), there is a 0.08 eV shift to a lower binding energy of the pumped spectrum relative to the unpumped one, confirming the p-type nature of SnS. The acceptor level energy due to tin vacancies is in close proximity to the Fermi level according to temperature-dependent Hall measurements. Figure 3 shows the temperature dependence of the majority carrier density of SnS from which the activation energy of tin vacancies was estimated to be 0.25 eV,31 close to the measured Fermi level of 0.28 eV. From a theoretical point of view, the calculated tin vacancy formation enthalpy requires the acceptor level energy to be below 0.5 eV,32 which is satisfied by the fitted value of 0.25 eV.
have a direct band gap of 1.28 eV and an indirect band gap of 1.10 eV, both of which are consistent with reported values.

The optical band gaps of Zn(O,S) are more difficult to determine. The optical properties of Zn(O,S) prepared by various methods have been extensively studied. Since there is a 16% lattice mismatch between hexagonal ZnO and cubic or hexagonal ZnS, Zn(O,S) with intermediate compositions experience decreased crystallinity and become either nanocrystalline or amorphous, or a mixture of both, in the range of 0.3 < S/Zn < 0.6. The optical band gaps of Zn(O,S) with S/Zn ratios of 0.37, 0.50, and 0.64 essentially fall into this intermediate range. Based on X-ray diffraction (XRD) analysis (not shown here), the three compositions are either highly disordered nanocrystalline or amorphous as they do not exhibit significant diffraction features. Other XRD analyses also confirm this finding.

The decrease in crystallinity in the intermediate range results in band gap bowing with a band gap minimum around halfway between ZnO and ZnS, where the lattice strain causes the films to separate into a two-phase structure. Because of the decreased crystallinity, the intermediate compositions exhibit long low energy absorption tails that make band gap extraction difficult. The tailing effect of Zn(O,S) with S/Zn ratios of 0.37, 0.50, and 0.64 can be observed in the fs-UPS spectra in Figure 2. Unlike polycrystalline SnS with a well-defined band gap, the three compositions of Zn(O,S) show significantly larger tailing of states into the band gap. This tailing effect introduces an uncertainty in determining the band gaps of Zn(O,S) and the CBOs of the heterojunctions.

For direct band-to-band transitions in crystalline films, band gaps are determined by linearly extrapolating the plot of \( (\chi h\nu)^2 \) versus \( h\nu \) to zero, while for amorphous films, band gaps are identified from the plot of \( (\chi h\nu)^{1/2} \) versus \( h\nu \) based on the Tauc model. Since the three compositions of Zn(O,S) could be either nanocrystalline or amorphous, two sets of band gaps were extracted from the same absorption spectra to account for both scenarios, as illustrated in Figures 4(a) and 4(b). In Figure 4(a), the band gaps of Zn(O,S) with S/Zn ratios of 0.37, 0.50, and 0.64 were determined to be \( E_g = 2.63, 2.78, \) and 3.08 eV, respectively, if the films were treated as nanocrystalline. Meanwhile, in Figure 4(b), the band gaps of the same films were found to be \( E_g = 2.57, 2.68, \) and 2.92 eV, respectively, if the films were treated as amorphous. The tailing effect in the optical measurements introduces an uncertainty of 10% in determining the band gaps. The shift of the absorption edge shows a clear trend of a larger band gap with an increasing S/Zn ratio as shown in Figure 4. These band gaps are comparable with reported theoretical and experimental values.

### Table I. Electronic properties of SnS/Zn(O,S) heterostructures with S/Zn ratios of 0.37, 0.50, and 0.64.

<table>
<thead>
<tr>
<th>S/Zn</th>
<th>VBO (eV)</th>
<th>SnS band bending (eV)</th>
<th>Zn(O,S) ( E_g ) (eV)</th>
<th>Zn(O,S) ( E_g ) (amorphous)</th>
<th>CBO (eV)</th>
<th>CBO (eV)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.37</td>
<td>1.36 ± 0.05</td>
<td>0.11 ± 0.02</td>
<td>2.63 ± 0.25</td>
<td>2.57 ± 0.25</td>
<td>0.17 ± 0.25</td>
<td>0.11 ± 0.25</td>
</tr>
<tr>
<td>0.50</td>
<td>1.31 ± 0.05</td>
<td>0.12 ± 0.02</td>
<td>2.78 ± 0.25</td>
<td>2.68 ± 0.25</td>
<td>0.37 ± 0.25</td>
<td>0.27 ± 0.25</td>
</tr>
<tr>
<td>0.64</td>
<td>1.12 ± 0.05</td>
<td>0.13 ± 0.02</td>
<td>3.08 ± 0.25</td>
<td>2.92 ± 0.25</td>
<td>0.86 ± 0.25</td>
<td>0.70 ± 0.25</td>
</tr>
</tbody>
</table>
The CBOs of the SnS/Zn(O,S) heterojunctions were calculated by combining the VBOs measured by fs-UPS with the band gaps of SnS and Zn(O,S) derived from the absorption spectra (Table I). The electronic structure diagram of the SnS/Zn(O,S) heterostructures was constructed schematically in Figure 5. Since there are two sets of band gaps associated with Zn(O,S), the CBOs for the nanocrystalline scenario are shown next to the amorphous one (in parentheses) in Figure 5. As the S/Zn ratio increases from 0.37 to 0.64, the CBO increases as a result of both a decreasing VBO and an increasing band gap. For the SnS/Zn(O,S) heterojunctions with S/Zn ratios of 0.37 and 0.50, barriers of 0.17 eV (0.11 eV) and 0.37 eV (0.27 eV) are both sufficiently low to enable unimpeded minority current flow from the SnS absorber layer into the Zn(O,S) buffer layer, consistent with the high $J_{sc}$ and large fill factor observed in Figure 1. For the SnS/Zn(O,S) heterojunction with a S/Zn ratio of 0.64, which is compared with the highest S/Zn-ratio device (S/Zn = 0.58) in Figure 1, the large barrier of 0.86 eV (0.70 eV) suppresses photocurrent collection, consistent with the observed lower $J_{sc}$, $V_{oc}$, and fill factor. While the band gaps of Zn(O,S) for the nanocrystalline and amorphous scenarios reveal relatively small quantitative differences that translate to equivalent differences in the CBOs, the same robust qualitative conclusions regarding minority carrier flow can be made. Hence, it is confirmed that CBOs play a critical role in the device performance of SnS/Zn(O,S) solar cells.

In summary, band alignment studies of SnS/Zn(O,S) heterojunctions with various compositions of Zn(O,S) were reported. The heterojunction VBOs, band bending, and Fermi level positions were extracted by fs-UPS. The band gaps were determined by optical transmission and reflection measurements. By combining these results, the CBOs were calculated and the electronic structure diagram was constructed. It was found that the SnS/Zn(O,S) heterojunctions with S/Zn ratios of 0.37 and 0.50 have desirable small positive CBOs, while the heterojunction with a S/Zn ratio of 0.64 produces an undesirable large positive CBO. The results,
consistent with previously measured solar cell characteristics, confirmed the critical dependence of device performance on CBOs. The measurement technique has been demonstrated as an effective tool for engineering band alignment in heterojunction thin film solar cells.

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